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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: **Masahiro HATAKEYAMA et al.**

Serial Number: **Not Yet Assigned**  
(§371 of international application No. PCT/JP03/04910)

Filed: **October 15, 2004**

For: **SAMPLE SURFACE INSPECTION APPARATUS AND METHOD**

Attorney Docket No. 042879  
Customer No.: 38834

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

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Sir:

In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449 and cited in the enclosed international search report. Since the references were cited in the international search report, it is believed that copies of the references have been transmitted by the International Bureau.

In the event there are any fees due in connection with the filing of this paper, please charge Deposit Account No. 50-2866.

Respectfully submitted,  
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Enclosures: PTO-1449 and international search report.

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<b>INFORMATION DISCLOSURE STATEMENT PTO-1449</b>	Atty. Docket No. 042879	Serial No. New Appln.
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**U.S. PATENT DOCUMENTS**

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
—	AA 5,889,282	Yang et al.	03/30/99			

**FOREIGN PATENT DOCUMENTS**

	Document No.	Date	Country	Translation (Yes or No)
—	AB 2001-83112	03/30/01	Japan	Cited in the PCT search report.
—	AC 1-320421	12/26/89	Japan	Cited in the PCT search report.
—	AD 2001-272363	10/05/01	Japan	Cited in the PCT search report.
—	AE 2-54155	02/23/90	Japan	Cited in the PCT search report.
—	AF 2002-75265	03/15/02	Japan	Cited in the PCT search report.
—	AG 6-308061	11/04/94	Japan	Cited in the PCT search report.

**OTHER DOCUMENTS**

—	AJ	
—	AK	
Examiner		Date Considered